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Applicati n Number 10/041,957 Substitute for form 1449A/PTO **Filing Dat** 1/7/02 INFORMATION DISCLOSURE First Named Inventor Steven Teig STATEMENT BY APPLICANT 2825 Group Art Unit (use as many sheets as necessary) Bihn Tat Examiner Name SPLX.P0044 7 Sheet Attorney Docket Number

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Applicati n Numb r 10/041,957 Substitute for form 1449A/PTO **Filing Date** 1/7/02 INFORMATION DISCLOSURE **First Named Inventor** Steven Teig STATEMENT BY APPLICANT 2825 **Group Art Unit** (use as many sheets as necessary) Bihn Tat Examiner Name SPLX.P0044 7 Sheet 2 Attorney Docket Number

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**Application Number** 10/041,957 Substitute for form 1449A/PTO 1/7/02 Filing Dat INFORMATION DISCLOSURE First Named Inv nt r Steven Teig STATEMENT BY APPLICANT 2825 **Group Art Unit** (use as many sheets as necessary) Bihn Tat **Examiner Name** SPLX.P0044 7 Sheet 3 Attorney Docket Number

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Application Number	10/041,957
Filing Date	1/7/02
First Named Inv nt r	Steven Teig
Group Art Unit	2825
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Atty/Secty: Serial/Patent No.: 10/041,957 Date Mailed: 9/26/2003 1/7/02 Filing Date: SPLX.P0044 Atty Docket: Steven Teig Applicant(s):

## TITLE: Method and Apparatus for Pre-Computing Routes

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Serial/Patent No.: 10/041,957

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Applicant(s):

Steven Teig

TITLE: Method and Apparatus for Pre-Computing Routes

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Filing Date	1/4/02
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Group Art Unit	
Examiner Name	
Attorney Docket Number	SPLX.P0044

			RELATED U.	S. PATENT DOCU	MENTS
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	14.	2003/0066043	01-13-2002	Steven Teig et al.	Continuation of 2003/0088844 per preliminary amendment.

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## principle (appropries agencing) m PTO-1449 (5 pages)

Serial/Patent No.: 10/041,957

Filing Date: Atty Docket:

1/7/02

SPLX.P0044

Applicant(s):

Steven Teig

TITLE: Method and Apparatus for Pre-Computing Routes

Atty/Secty:

Date Mailed: 4/23/2003

The following has been received by the U.S. Patent & Trademark Office on the date stamped hereon:

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Information Disclosure Statement (2 pages)

3. Form PTO-1449 (5 pages)

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**Application Number** 10/041,957 Substitute for form 1449A/PTO Filing Date 1/7/02 INFORMATION DISCLOSURE First Named Inventor Steven Teig STATEMENT BY APPLICANT Group Art Unit 2825 (use as many sheets as necessary) **Examiner Name** 2 Sheet 2 of Attorney Docket Number SPLX.P0044

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**Application Number** 10/041,957 Substitute for form 1449A/PTO **Filing Date** 1/7/02 INFORMATION DISCLOSURE First Named Inventor Steven Teig STATEMENT BY APPLICANT Group Art Unit 2825 (use as many sheets as necessary) Examiner Name 3 Sheet 3 of Attorney Docket Number SPLX.P0044

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